

Notice of References Cited

Application/Control No.

10/520,349

Applicant(s)/Patent Under

Reexamination

NAGASAWA, ATSUSHI

Examiner

HAMID R. BADR

Art Unit

4174

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U.S. PATENT DOCUMENTS

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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NON-PATENT DOCUMENTS

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
U	Nakagawa, S. et al., 1994. Construction from a single parent of baker's yeast strains with high freeze tolerance and fermentative activity in both lean and sweet doughs. Appl. Environmental Microbiol. 60 (10): 3499-3502
V	
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